Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | VAN HOUZEN ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,039,384	03-2000	Schulte et al.	296/146.2
	В	US-5,649,405	07-1997	Morihara et al.	296/146.2
	С	US-5,555,677	09-1996	DeRees et al.	296/146.2
	D	US-2004/0088925	05-2004	Nozaki, Masahiro	049/498.1
	E	US-2001/0054261	12-2001	NOZAKI et al.	49/498.1
	F	US-5,352,009	10-1994	Takeuchi, Norio	296/146.9
	G	US-5,347,758	09-1994	Yamane, Tadanao	49/484.1
	Н	US-3,603,035	09-1971	Kaldenberg, Henry J.	49/489.1
	ı	US-5,489,104	02-1996	Wolff, Helmut	49/498.1
	J	US-6,007,140	12-1999	Heitmann et al.	296/146.9
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	И					
	0					
	Р	*				
	O					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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